Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/666,875	MAKELA ET AL.		
Examiner	Art Unit		
PHUOC H DOAN	2687		

	SEARCHED		
Class	Subclass	Date	Examiner
455	509	07/12/05	PHD
	518		
345	762		
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709	204		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
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